

Specification for Approval

Date: 2023/03/08

	Custor	ner:					
•	TAI-TECH P/N:	HPC160809HC-SE	RIES				
	CUSTOMER P/N:						
	DESCRIPTION:						
	QUANTITY:	pcs	<u>:</u>				
REM	ARK:						
	Cu	stomer Approval Feedba	ick				

□ 西北臺慶科技股份有限公司

TAI-TECH Advanced Electronics Co., Ltd <u>Headquarter:</u>
NO.1 YOU 4TH ROAD, YOUTH INDUSTRIAL DISTRICT, YANG-MEI, TAO-YUAN HSIEN, TAIWAN, R.O.C.
TEL: +886-3-4641148 FAX: +886-3-4643565
http://www.tai-tech.com.tw

E-mail: sales@tai-tech.com.tw

□ 臺慶精密電子(昆山)有限公司

TAI-TECH ADVÂNCÉD ELECTRONICS(KUNSHAN) CO., LTD SHINWHA ROAD, KUNJIA HI-TECH INDUSTRIAL PARK, KUN-SHAN, JIANG-SU, CHINA

TEL: +86-512-57619396 FAX: +86-512-57619688

E-mail: sales@tai-tech.cn

■ 慶邦電子元器件(泗洪)有限公司

TAIPAQ ELECTRONICS (SIHONG) CO., LTD
JIN SHA JIANG ROAD, CONOMIC DEVELOPMENT ZONE SIHONG,

JIANGSU , CHINA.
TEL: +86-527-88601191 FAX: +86-527-88601190

E-mail: sales@taipaq.cn

Sales Dep.

APPROVED	CHECKED
Eric Kuan	Zhang Mengmeng

R&D Center

APPROVED	CHECKED	DRAWN
Sky Luo	Mr.Liang	Xu yaoyao

Power Inductor

HPC160809HC-SERIES

		ECN HISTORY LIS	ST		
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN
1.0	23/03/08	New Issue	Sky Luo	Mr.Liang	Xu yaoyao
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Power Inductor

HPC160809HC-SERIES

1. Features

- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.
- 3. Operating temperature :-40~+125 $^{\circ}\mathbb{C}$ (Including self temperature rise)

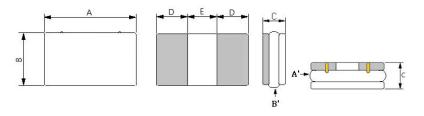




2. Applications

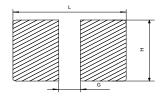
Commercial applications

2. Dimension



A(mm)	A'(mm)	B(mm)	B'(mm)	C(mm)	D(mm)	E(mm)
1.60±0.15	1.90 Max	0.90±0.15	1.10 Max	0.85±0.10	0.55±0.15	0.50±0.15

Recommended Land pattern



L(mm)	G(mm)	H(mm)
1.80	0.60	0.96

Note: 1. The above PCB layout reference only. 2. Recommend solder paste thickness at 0.10mm and above.

3. Part Numbering

HPC	160809	HC -	4 R7	M
Α	В	С	D	Е

- A: Series
- B: Dimension
- C: Lead Free High current
 D: Inductance 4R7=4.70uH
- E: Inductance Tolerance $K=\pm 10\%$, $L=\pm 15\%$, $M=\pm 20\%$, $Y=\pm 30\%$.

4. Specification

TAI-TECH	Inductance	Inductance (uH)±20		I sat (A)		DCR (mΩ)	
Part Number	(uH)±20 @ 0 A	Тур	Max	Тур	Max	Тур	Max
HPC160809HC-1R0M	1.00	0.95	0.88	1.10	0.95	193	231
HPC160809HC-1R5M	1.50	0.75	0.66	0.85	0.78	260	312
HPC160809HC-2R2M	2.20	0.60	0.55	0.69	0.65	410	492
HPC160809HC-3R3M	3.30	0.50	0.45	0.58	0.50	550	660
HPC160809HC-4R7M	4.70	0.40	0.36	0.45	0.40	670	770
HPC160809HC-6R8M	6.80	0.35	0.30	0.40	0.35	1145	1375
HPC160809HC-100M	10.0	0.30	0.25	0.32	0.28	1375	1650
HPC160809HC-150M	15.0	0.25	0.23	0.27	0.23	2000	2400
HPC160809HC-220M	22.0	0.20	0.18	0.22	0.20	3575	4290

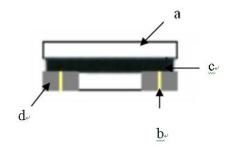
Note:

- 1. Test frequency: Ls: 1MHz /1.0V.
- 3. Testing Instrument(or equ): Agilent 4284A,E4991A,4339B,KEYSIGHT E4980A/AL,chroma3302,3250,16502.
- 4. Heat Rated Current (Irms) will cause the coil temperature rise approximately $\,^{\Delta}\,T$ of 40 $^{\circ}\!C$
- 5. Saturation Current (Isat) will cause L0 to drop approximately 30%.
- 6. The part temperature (ambient + temp rise) should not exceed 125°C under worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.
- 7. Irms Testing: Temperature rise is highly dependent on many factors including pcb land pattern, trace size, and proximity to other components.

 Therefore temperature rise should be verified in application conditions.
- 8. Rated DC current: The lower value of Irms and Isat.

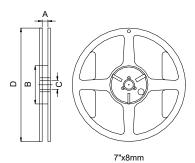
5. Material List

No.	Description	Specification
a.	Core	Ferrite Core
b.	Wire	Enameled Copper Wire
С	Glue	Epoxy with magnetic powder
d	Terminal	Ag/Ni/Sn



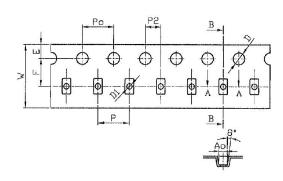
6. Packaging Information

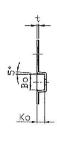
6-1. Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
7"x8mm	8.4±1.0	50 min	13±0.8	178±2

6-2. Tape Dimension



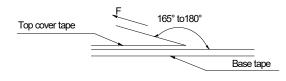


W(mm)	P(mm)	E(mm)	F(mm)	P2(mm)	D(mm)	D1(mm)	Bo(mm)	Ao(mm)	Ko(mm)	Po(mm)	t(mm)
8.00±0.10	4.00±0.10	1.75±0.10	3.50±0.05	2.00±0.05	1.50±0.10	0.70±0.10	1.96±0.10	1.05±0.10	1.05±0.10	4.00±0.10	0.23±0.05

6-3. Packaging Quantity

Chip size	160809
Chip / Reel	3000

6-4. Tearing Off Force



The force for tearing off cover tape is 10 to 100 grams in the arrow direction under the following conditions(referenced ANSI/EIA-481-D-2008 of 4.11 standard).

Tearing Speed	Room Temp.	Room Humidity	Room atm
mm	(℃)	(%)	(hPa)
300±10%	5~35	45~85	860~1060

7.Reliability and Test Condition

Item	Performance	Test Condition
Operating temperature	-40~+125℃ (Including self - temperature rise)	
	110~+40℃,50~60%RH (Product with taping)	
Storage temperature	240~+125℃(on board)	
Electrical Performance Tes	st	
		HP4284A,CH11025,CH3302,CH1320,CH1320S
Inductance	Refer to standard electrical characteristics list.	LCR Meter.
DCR		CH16502,Agilent33420A Micro-Ohm Meter.
		Saturation DC Current (Isat) will cause L0
Saturation Current (Isat)	Approximately △L30%.	to drop △L(%)
		Heat Rated Current (Irms) will cause the coil temperature rise
		$\triangle T(^{\circ}C)$ without core loss.
Heat Rated Current (Irms)	Approximately △T40℃	1.Applied the allowed DC current
		2.Temperature measured by digital surface thermometer
Reliability Test		
Life Test		Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles) Temperature: 125±2°C(Inductor, ambient + temp rise) Applied current: rated current Duration: 1000±12hrs Measured at room temperature after placing for 24±2 hrs
Load Humidity		Preconditioning: Run through IR reflow for 3times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) Humidity: $85\pm2\%$ R.H, Temperature: $85\%\pm2\%$ Duration: 1000hrs Min. Bead:with 100% rated current, Inductance: with 100% rated current Measured at room temperature after placing for 24±2 hrs.
Moisture Resistance	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within±15% of initial value and shall not exceed the specification value	Preconditioning: Run through IR reflow for 3 times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) 1. Baked at50°C for 25hrs, measured at room temperature after placing for 4 hrs. 2. Raise temperature to 65 ± 2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs. 3. Raise temperature to 65 ± 2°C 90-100%RH in 2.5hrs, and keep 3 hours, cool down to 25°C in 2.5hrs, keep 3 hours, cool down to 25°C in 2.5hrs, keep at 25°C for 2 hrs then keep at -10°C for 3 hrs 4. Keep at 25°C 80-100%RH for 15min and vibrate at the frequency of 10 to 55 Hz to 10 Hz, measure at room temperature after placing for 1~2 hrs.
Thermal shock		Preconditioning: Run through IR reflow for 3 times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) Condition for 1 cycle Step1: $-40\pm2^{\circ}$ C 30 ± 5 min Step2: $125\pm2^{\circ}$ C $=0.5$ min Step3: $125\pm2^{\circ}$ C 30 ± 5 minNumber of cycles: 500 Measured at room fempraturc after placing for 24 ± 2 hrs.
Vibration		Preconditioning: Run through IR reflow for 3 times. (IPC/JEDECJ-STD-020E Classification Reflow Profiles) Oscillation Frequency: 10Hz~2KHz~10Hz for 20 minutes Equipment: Vibration checker Total Amplitude: 10g Testing Time: 12 hours(20 minutes, 12 cycles each of 3 orientations).

Item	Performance	Test Condition		
Bending	Appearance: No damage. Inductance: within±10% of initial value	Shall be mounted on a FR4 substrate of the following dimensions: >=0805 inch(2012mm):40x100x1.2mm <0805 inch(2012mm):40x100x0.8mm Bending depth: >=0805 inch(2012mm):1.2mm <0805 inch(2012mm):0.8mm duration of 10 sec.		
	C: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value	Type Peak Normal Wave change (g's) (ms) Wave form (Vi)ft/sec		
Shock		SMD 50 11 Half-sine 11.3		
		Lead 50 11 Half-sine 11.3		
		shocks in each direction along 3 perpendicular axes(18 shocks).		
Solderability	More than 95% of the terminal electrode should	a. Method B1, 4 hrs @155°C dry heat @255°C±5°C Test time:5 +0/-0.5 seconds.		
	be covered with solder.	b. Method D category 3. (steam aging 8hours ± 15 min)@ 260°C±5°C Test time: 30 +0/-0.5 seconds.		
Resistance to Soldering Heat		Depth: completely cover the termination Temperature(°C) Time(s) Temperature ramp/immersion and emersion rate Number of heat cycles		
		260 ±5 (solder temp) 10 ±1 25mm/s ±6 mm/s 1		
	Appearance: No damage. Inductance: within±10% of initial value Q: Shall not exceed the specification value. RDC: within ±15% of initial value and shall not exceed the specification value e	Preconditioning: Run through IR reflow for 3 times.(IPC/JEDEC J-STD-020E Classification Reflow Profiles With the component mounted on a PCB with the device to be tested, applyaforce(-0805inch(2012mm):1kg,<=0805inch(2012mm):0.5kg)to the side of a device being tested. This force shall be applied for 60 +1 seconds. Also the force shall be applied gradually as not to apply a shock to the component being tested.		
Terminal Strength		DUT wide thick substrate press tool		

Note: When there are questions concerning measurement result: measurement shall be made after 48 ± 2 hours of recovery under the standard condition.

8. Soldering Specifications

(1) Soldering

Mildly activated rosin fluxes are preferred. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

(2) Soldering Reflow:

Recommended temperature profiles for lead free re-flow soldering in Figure 1. Table 1.1&1.2 (J-STD-020E)

(3) Iron Reflow:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended. (Fig. 2)

- · Preheat circuit and products to 150℃
- · Never contact the ceramic with the iron tip

· 1.0mm tip diameter (max)

- · Use a 20 watt soldering iron with tip diameter of 1.0mm
- · Limit soldering time to 4~5sec.

Fig.1 Soldering Reflow

· 355°C tip temperature (max)

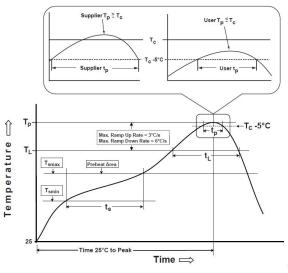
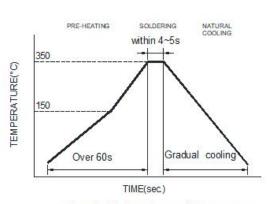


Fig.2 Iron soldering temperature profiles



Iron Soldering times: 1 times max. Soldering iron Method: 350±5℃ max

Reflow times: 3 times max

Table (1.1): Reflow Profiles

Profile Type:	Pb-Free Assembly
Preheat	
-Temperature Min(T _{smin})	150℃
-Temperature Max(T _{smax})	200℃
-Time(t_s)from(T_{smin} to T_{smax})	60-120seconds
Ramp-up rate(T _L to T _p)	3℃/second max.
Liquidus temperature(T _L)	217℃
Time(t _L)maintained above T _L	60-150 seconds
Classification temperature(T _c)	See Table (1.2)
Time(t_p) at Tc- 5° C (Tp should be equal to or less than Tc.)	*< 30 seconds
Ramp-down rate(Tp to TL)	6℃ /second max.
Time 25℃ to peak temperature	8 minutes max.

Tp: maximum peak package body temperature, Tc: the classification temperature.

Table (1.2) Package Thickness/Volume and Classification Temperature (Tc)

	Package Thickness	Volume mm ³ <350	Volume mm ³ 350-2000	Volume mm ³ >2000
	<1.6mm	260℃	260℃	260℃
PB-Free Assembly	1.6-2.5mm	260°C	250°C	245°C
	≥2.5mm	250°C	245°C	245°C

Reflow is referred to standard IPC/JEDEC J-STD-020E.

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For user (customer) **Tp** should be equal to or less than **Tc.**

^{*} Tolerance for peak profile temperature (Tp) is defined as a supplier minimum and a user maximum.

9.Notes

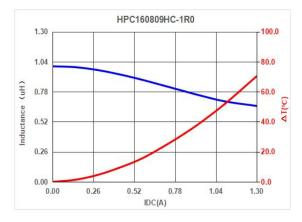
(1) When there are questions concerning measurement result : measurement shall be made after 48 ± 2 hours of recovery under the standard condition

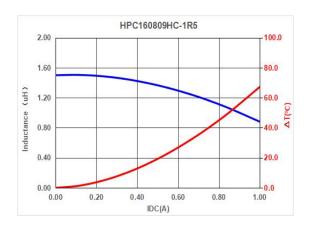
- (2) This power choke coil itself does not have any protective function in abnormal condition such as overload, short-circuit and open-circuit conditions, etc. Therefore, it shall be confirmed as the end product that there is no risk of smoking, fire, dielectric withstand voltage, insulation resistance, etc. in abnormal conditions to provide protective devices and/or protection circuit in the end product.
- (3) When this power choke coil was used in a similar or new product to the original one, sometimes it might not be able to satisfy the specifications due to different condition of use.
- (4) Dielectric withstanding test with higher voltage than specific value will damage insulating material and shorten its life.
- (5) This power choke coil must not be used in wet condition by water, coffee or any liquid because insulation strength becomes very low in this condition.
- (6) Please consult our company to confirm the reliability of the process required to wash or use or exposure to a chemical solvent used in this product. PCB washing tested to MIL-STD-202 Method, and dry it off immediately.
- (7) The rated current as listed is either the saturation current or the heating current depending on which value is lower.
- (8) If this power choke is dipped in the cleaning agent, such as toluene, xylene, ketone, and ether system, there is a possibility that the performance decreases greatly, and marking disappearnc.
- (9) The high power ultrasonic washing may damage the choke body.
- (10) Before use, the user should determine whether this product is suitable for their own design. Our company only guarantees that the product meets the requirements of this specification.

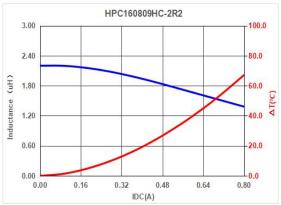
Application Notice

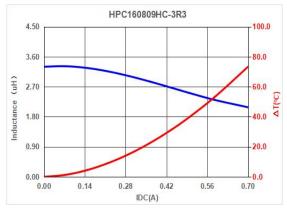
- · Storage Conditions
 - To maintain the solderability of terminal electrodes:
 - 1. TAI-TECHproducts meet IPC/JEDEC J-STD-020E standard-MSL, level 1.
 - 2. Temperature and humidity conditions: Less than 40 $^{\circ}$ C and 60% RH.
 - 3. Recommended products should be used within 12 months form the time of delivery.
 - 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- · Transportation
 - 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
 - 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
 - 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.

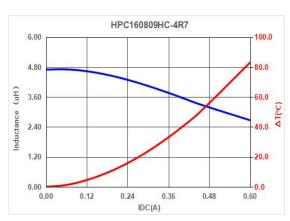
10. Typical Performance Curves

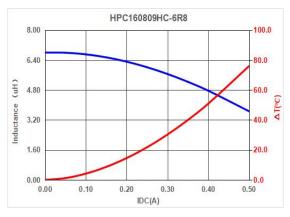


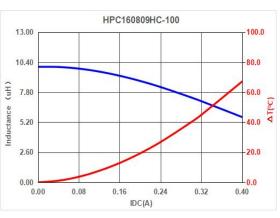


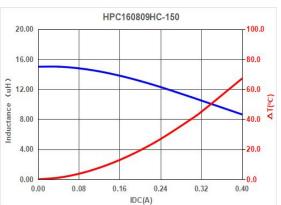


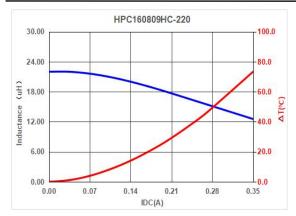












11. Appearance criterion

11-1 Core chipping

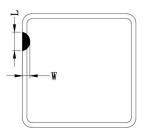
The appearance standard of the chipping size on top side, and bottom side ferrite core is listed below.

Chip off is generated during molding and manufacturing process.

Chip off acceptance limits subjected to the product size.

Our current Defect limit is based on the IPC-A-610.

Some chip off does not impact the product function, see the IPC standard 1 & 2.

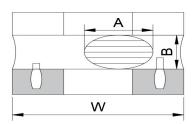


L	≤50 % of the length
W	≤25 % of the width

Defects usually occur at the corners and edges of the product, There will be a slight defect black and rough, but not exposed copper, and does not affect the product performance and reliability.

11-2 Void appearance tolerance Limit

Size of voids occurring to coating resin is specified below.



Exposed wire tolerance limit of coating resin part on product side.

Size of exposed wire occurring to coating resin is specified below.

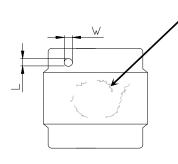
- 1. Width direction (dimension a): Acceptable when $a \le w/2$.
- 2. Length direction (dimension b): Dimension b is not specified.
- 3. The total area of exposed wire occurring to each sides is not greater than 50% of coating resin area, and is acceptable.

11-3 External appearance criterion for exposed wire

Exposed winding wire at the secondary side is regarded as qualified product.



11-4. Electrode appearance criterion for exposed wire



Visual check on core surface with no crack means pass.

Only top side of wire is exposed. (regardless of whole tope side of wire exposed)

Conforming

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Less than 1/2 of joint side length. (More than 1/2 is selected as defect)

Wire is soldered insufficiently and less than half of outer diameter is covered with solder.

L&w ≤20% of the area on one single pad Foreign materials on the product body is inevitable and accepted. Electrodes with foreign body (dirt) appearance standards Foreign materials (dirt) will not affect the coplanarity of PAD, below the example of foreign materials (dirt) quantity ≤2PCS on single PAD. Dimensions range as shown in the table.

单击下面可查看定价,库存,交付和生命周期等信息

>>TAI-TECH(台庆)